



Silicon PIN Photodiode

Description

BPW41N is a high speed and high sensitive PIN photodiode in a flat side view plastic package.

The epoxy package itself is an IR filter, spectrally matched to GaAs or GaAs on GaAlAs IR emitters ($\lambda_D = 950 \text{ nm}$).

The large active area combined with a flat case gives a high sensitivity at a wide viewing angle.

Features

- Large radiant sensitive area (A=7.5 mm²)
- Wide angle of half sensitivity $\varphi = \pm 65^{\circ}$
- High radiant sensitivity
- Fast response times
- Small junction capacitance
- Plastic case with IR filter (λ=950 nm)
- Suitable for near infrared radiation

Applications

High speed photo detector

Absolute Maximum Ratings

 $T_{amb} = 25^{\circ}C$

| Parameter | Test Conditions | Symbol | Value | Unit |
|-------------------------------------|------------------------------|------------------|-----------------|------|
| Reverse Voltage | | V_{R} | 60 | V |
| Power Dissipation | $T_{amb} \leq 25 ^{\circ}C$ | P_V | 215 | mW |
| Junction Temperature | | T _i | 100 | °C |
| Storage Temperature Range | | T _{stg} | <i>–</i> 55+100 | °C |
| Soldering Temperature | t ≦ 5 s | T _{sd} | 260 | °C |
| Thermal Resistance Junction/Ambient | | R_{thJA} | 350 | K/W |

94 8480

Vishay Semiconductors



Basic Characteristics

 $T_{amb} = 25^{\circ}C$

| Parameter | Test Conditions | Symbol | Min | Тур | Max | Unit |
|-------------------------------------|---|-------------------|-----|---------------------|-----|--------|
| Breakdown Voltage | $I_R = 100 \mu\text{A}, E = 0$ | V _(BR) | 60 | | | V |
| Reverse Dark Current | V _R = 10 V, E = 0 | Ìro | | 2 | 30 | nA |
| Diode Capacitance | $V_R = 0 \text{ V, } f = 1 \text{ MHz, } E = 0$ | C_D | | 70 | | pF |
| | $V_R = 3 \text{ V, f} = 1 \text{ MHz, E} = 0$ | C_D | | 25 | 40 | pF |
| Open Circuit Voltage | $E_e = 1 \text{ mW/cm}^2, \lambda = 950 \text{ nm}$ | V_{o} | | 350 | | mV |
| Temp. Coefficient of Vo | $E_e = 1 \text{ mW/cm}^2, \lambda = 950 \text{ nm}$ | TK_Vo | | -2.6 | | mV/K |
| Short Circuit Current | $E_e = 1 \text{ mW/cm}^2, \lambda = 950 \text{ nm}$ | l _k | | 38 | | μΑ |
| Temp. Coefficient of I _k | $E_e = 1 \text{ mW/cm}^2, \lambda = 950 \text{ nm}$ | TK _{lk} | | 0.1 | | %/K |
| Reverse Light Current | $E_e = 1 \text{ mW/cm}^2$, $\lambda = 950 \text{ nm}$, $V_R = 5 \text{ V}$ | I _{ra} | 43 | 45 | | μΑ |
| Angle of Half Sensitivity | | φ | | ±65 | | deg |
| Wavelength of Peak Sensitivity | | λ_{p} | | 950 | | nm |
| Range of Spectral Bandwidth | | $\lambda_{0.5}$ | | 8701050 | | nm |
| Noise Equivalent Power | $V_R = 10 \text{ V}, \ \lambda = 950 \text{ nm}$ | NEP | | 4x10 ⁻¹⁴ | | W/√ Hz |
| Rise Time | $V_R = 10 \text{ V}, R_L = 1 \text{k } \Omega,$ $\lambda = 820 \text{ nm}$ | t _r | | 100 | | ns |
| Fall Time | $V_R = 10 \text{ V}, R_L = 1 \text{k } \Omega,$ $\lambda = 820 \text{ nm}$ | t _f | | 100 | | ns |

Typical Characteristics $(T_{amb} = 25^{\circ}C \text{ unless otherwise specified})$

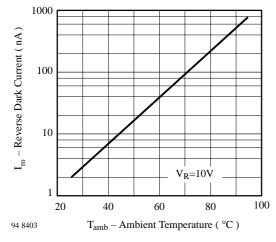


Figure 1. Reverse Dark Current vs. Ambient Temperature

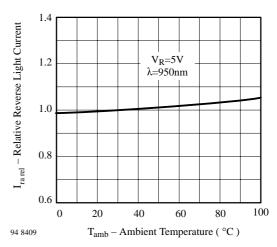


Figure 2. Relative Reverse Light Current vs.
Ambient Temperature





Vishay Semiconductors

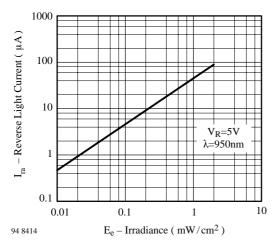


Figure 3. Reverse Light Current vs. Irradiance

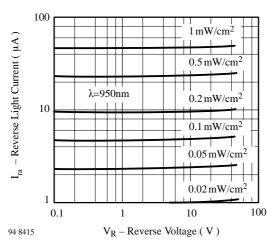


Figure 4. Reverse Light Current vs. Reverse Voltage

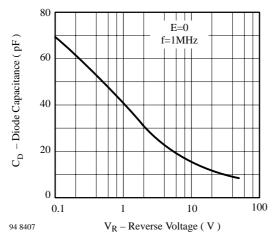


Figure 5. Diode Capacitance vs. Reverse Voltage

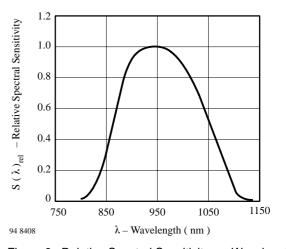


Figure 6. Relative Spectral Sensitivity vs. Wavelength

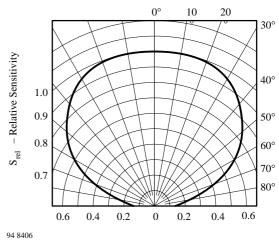


Figure 7. Relative Radiant Sensitivity vs. Angular Displacement

Vishay Semiconductors

VISHAY

Dimensions in mm

